

**Notice of References Cited**Application/Control No.  
**09/855,820**Applicant(s)/Patent Under Reexam  
**Madrid**Examiner  
**Edward Wojciechowicz**Art Unit  
**2815**

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**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	2002/0074147	6/2002	Tan et al	257	668
B	2002/0050912	5/2002	Shrier et al	257	668
C					
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**FOREIGN PATENT DOCUMENTS**

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